

## 阅读申明

- 1.本站收集的数据手册和产品资料都来自互联网，版权归原作者所有。如读者和版权方有任何异议请及时告之，我们将妥善解决。
- 2.本站提供的中文数据手册是英文数据手册的中文翻译，其目的是协助用户阅读，该译文无法自动跟随原稿更新，同时也可能存在翻译上的不当。建议读者以英文原稿为参考以便获得更精准的信息。
- 3.本站提供的产品资料，来自厂商的技术支持或者使用者的心得体会等，其内容可能存在描述上的差异，建议读者做出适当判断。
- 4.如需与我们联系，请发邮件到marketing@iczoom.com，主题请标有“数据手册”字样。

## Read Statement

1. The datasheets and other product information on the site are all from network reference or other public materials, and the copyright belongs to the original author and original published source. If readers and copyright owners have any objections, please contact us and we will deal with it in a timely manner.
2. The Chinese datasheets provided on the website is a Chinese translation of the English datasheets. Its purpose is for reader's learning exchange only and do not involve commercial purposes. The translation cannot be automatically updated with the original manuscript, and there may also be improper translations. Readers are advised to use the English manuscript as a reference for more accurate information.
3. All product information provided on the website refer to solutions from manufacturers' technical support or users the contents may have differences in description, and readers are advised to take the original article as the standard.
4. If you have any questions, please contact us at marketing@iczoom.com and mark the subject with "Datasheets" .



## 3.3V ZERO DELAY CLOCK BUFFER

**IDT2305B**

### FEATURES:

- Phase-Lock Loop Clock Distribution
- 10MHz to 133MHz operating frequency
- Distributes one clock input to one bank of five outputs
- Zero Input-Output Delay
- Output Skew < 250ps
- Low jitter <175 ps cycle-to-cycle
- 50ps typical cycle-to-cycle jitter (15pF, 66MHz)
- IDT2305B-1 for Standard Drive
- IDT2305B-1H for High Drive
- No external RC network required
- Operates at 3.3V V<sub>DD</sub>
- Power down mode
- Available in SOIC and TSSOP packages

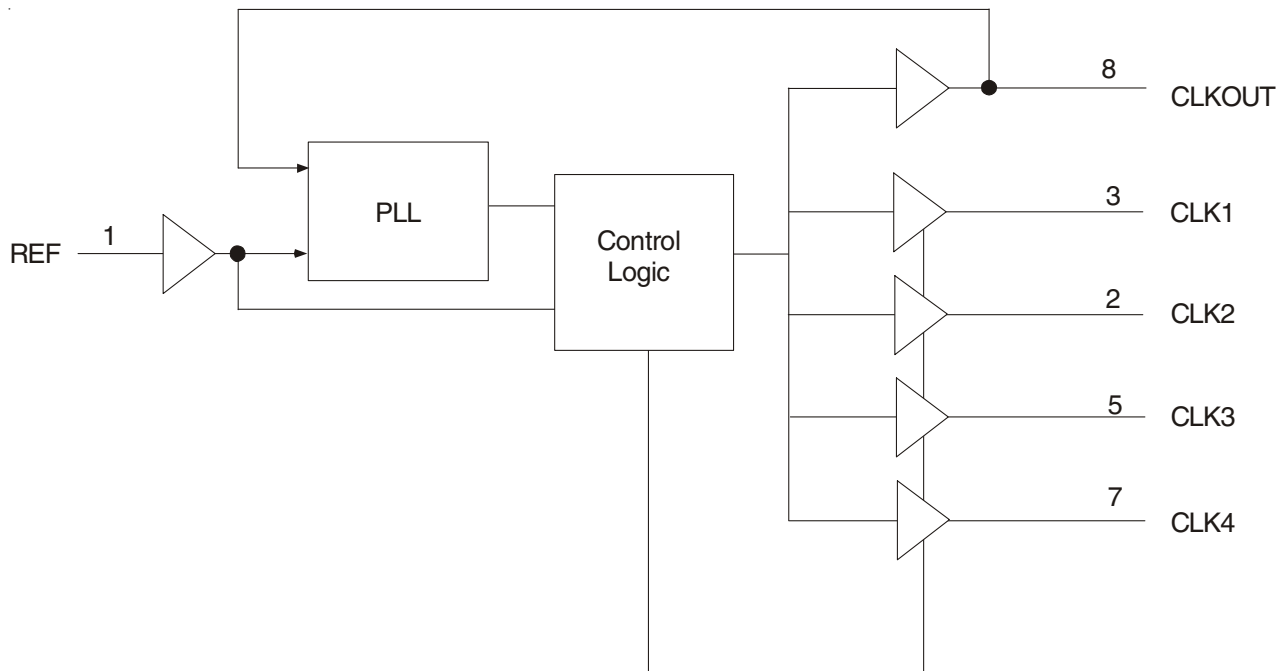
### DESCRIPTION:

The IDT2305B is a high-speed phase-lock loop (PLL) clock buffer, designed to address high-speed clock distribution applications. The zero delay is achieved by aligning the phase between the incoming clock and the output clock, operable within the range of 10 to 133MHz.

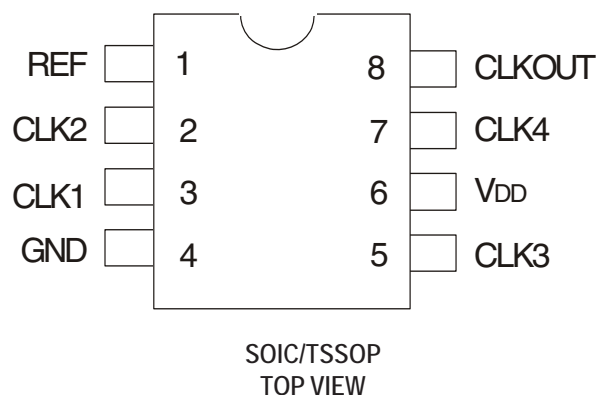
The IDT2305B is an 8-pin version of the IDT2309B. IDT2305B accepts one reference input, and drives out five low skew clocks. The -1H version of this device operates, up to 133MHz frequency and has a higher drive than the -1 device. All parts have on-chip PLLs which lock to an input clock on the REF pin. The PLL feedback is on-chip and is obtained from the CLKOUT pad. In the absence of an input clock, the IDT2305B enters power down. In this mode, the device will draw less than 25 $\mu$ A, the outputs are tri-stated, and the PLL is not running, resulting in a significant reduction of power.

The IDT2305B is characterized for both Industrial and Commercial operation.

### FUNCTIONAL BLOCK DIAGRAM



## PIN CONFIGURATION



## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Symbol	Rating	Max.	Unit
V <sub>DD</sub>	Supply Voltage Range	-0.5 to +4.6	V
V <sub>I</sub> <sup>(2)</sup>	Input Voltage Range (REF)	-0.5 to +5.5	V
V <sub>I</sub>	Input Voltage Range (except REF)	-0.5 to V <sub>DD</sub> +0.5	V
I <sub>IK</sub> (V <sub>I</sub> < 0)	Input Clamp Current	-50	mA
I <sub>O</sub> (V <sub>O</sub> = 0 to V <sub>DD</sub> )	Continuous Output Current	±50	mA
V <sub>DD</sub> or GND	Continuous Current	±100	mA
T <sub>A</sub> = 55°C (in still air) <sup>(3)</sup>	Maximum Power Dissipation	0.7	W
T <sub>STG</sub>	Storage Temperature Range	-65 to +150	°C
Operating Temperature	Commercial Temperature Range	0 to +70	°C
Operating Temperature	Industrial Temperature Range	-40 to +85	°C

### NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

## APPLICATIONS:

- SDRAM
- Telecom
- Datacom
- PC Motherboards/Workstations
- Critical Path Delay Designs

## PIN DESCRIPTION

Pin Name	Pin Number	Type	Functional Description
REF	1	IN	Input reference clock, 5 Volt tolerant input
CLK2 <sup>(1)</sup>	2	Out	Output clock
CLK1 <sup>(1)</sup>	3	Out	Output clock
GND	4	Ground	Ground
CLK3 <sup>(1)</sup>	5	Out	Output clock
V <sub>DD</sub>	6	PWR	3.3V Supply
CLK4 <sup>(1)</sup>	7	Out	Output clock
CLKOUT <sup>(1)</sup>	8	Out	Output clock, internal feedback on this pin

### NOTES:

- Weak pull down on all outputs.

### OPERATING CONDITIONS - COMMERCIAL

Symbol	Parameter	Min.	Max.	Unit
VDD	Supply Voltage	3	3.6	V
TA	Operating Temperature (Ambient Temperature)	0	70	°C
CL	Load Capacitance < 100MHz	—	30	pF
	Load Capacitance 100MHz - 133MHz	—	10	
CIN	Input Capacitance	—	7	pF

### DC ELECTRICAL CHARACTERISTICS - COMMERCIAL

Symbol	Parameter	Conditions		Min.	Max.	Unit
VIL	Input LOW Voltage Level			—	0.8	V
VIH	Input HIGH Voltage Level			2	—	V
IIL	Input LOW Current	VIN = 0V		—	50	µA
IiH	Input HIGH Current	VIN = VDD		—	100	µA
VOL	Output LOW Voltage	Standard Drive	IOL = 8mA	—	0.4	V
		High Drive	IOL = 12mA (-1H)			
VOH	Output HIGH Voltage	Standard Drive	IOH = -8mA	2.4	—	V
		High Drive	IOH = -12mA (-1H)			
IDD_PD	Power Down Current	REF = 0MHz		—	12	µA
IDD	Supply Current	Unloaded Outputs at 66.66MHz		—	32	mA

### SWITCHING CHARACTERISTICS (2305B-1) - COMMERCIAL <sup>(1,2)</sup>

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
tf	Output Frequency	10pF Load	10	—	133	MHz
		30pF Load	10	—	100	
	Duty Cycle = t2 ÷ t1	Measured at 1.4V, FOUT = 66.66MHz	40	50	60	%
tr	Rise Time	Measured between 0.8V and 2V	—	—	2.5	ns
tf	Fall Time	Measured between 0.8V and 2V	—	—	2.5	ns
ts	Output to Output Skew	All outputs equally loaded	—	—	250	ps
td	Delay, REF Rising Edge to CLKOUT Rising Edge	Measured at VDD/2	—	0	±350	ps
tr	Device-to-Device Skew	Measured at VDD/2 on the CLKOUT pins of devices	—	0	700	ps
tj	Cycle-to-Cycle Jitter	Measured at 66.66MHz, loaded outputs	—	50	175	ps
tLOCK	PLL Lock Time	Stable power supply, valid clock presented on REF pin	—	—	1	ms

NOTES:

1. REF Input has a threshold voltage of VDD/2.
2. All parameters specified with loaded outputs.

## SWITCHING CHARACTERISTICS (2305B-1H) - COMMERCIAL <sup>(1,2)</sup>

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t <sub>1</sub>	Output Frequency	10pF Load	10	—	133	MHz
		30pF Load	10	—	100	
	Duty Cycle = t <sub>2</sub> ÷ t <sub>1</sub>	Measured at 1.4V, F <sub>OUT</sub> = 66.66MHz	40	50	60	%
	Duty Cycle = t <sub>2</sub> ÷ t <sub>1</sub>	Measured at 1.4V, F <sub>OUT</sub> <50MHz	45	50	55	%
t <sub>3</sub>	Rise Time	Measured between 0.8V and 2V	—	—	1.5	ns
t <sub>4</sub>	Fall Time	Measured between 0.8V and 2V	—	—	1.5	ns
t <sub>5</sub>	Output to Output Skew	All outputs equally loaded	—	—	250	ps
t <sub>6</sub>	Delay, REF Rising Edge to CLKOUT Rising Edge	Measured at V <sub>DD</sub> /2	—	0	±350	ps
t <sub>7</sub>	Device-to-Device Skew	Measured at V <sub>DD</sub> /2 on the CLKOUT pins of devices	—	0	700	ps
t <sub>8</sub>	Output Slew Rate	Measured between 0.8V and 2V using Test Circuit #2	1	—	—	V/ns
t <sub>J</sub>	Cycle-to-Cycle Jitter	Measured at 66.66MHz, loaded outputs	—	—	175	ps
t <sub>LOCK</sub>	PLL Lock Time	Stable power supply, valid clock presented on REF pin	—	—	1	ms

NOTES:

1. REF Input has a threshold voltage of V<sub>DD</sub>/2.
2. All parameters specified with loaded outputs.

## OPERATING CONDITIONS - INDUSTRIAL

Symbol	Parameter	Min.	Max.	Unit
V <sub>DD</sub>	Supply Voltage	3	3.6	V
T <sub>A</sub>	Operating Temperature (Ambient Temperature)	-40	+85	°C
C <sub>L</sub>	Load Capacitance < 100MHz	—	30	pF
	Load Capacitance 100MHz - 133MHz	—	10	
C <sub>IN</sub>	Input Capacitance	—	7	pF

## DC ELECTRICAL CHARACTERISTICS - INDUSTRIAL

Symbol	Parameter	Conditions		Min.	Max.	Unit
V <sub>IL</sub>	Input LOW Voltage Level			—	0.8	V
V <sub>IH</sub>	Input HIGH Voltage Level			2	—	V
I <sub>IL</sub>	Input LOW Current	V <sub>IN</sub> = 0V		—	50	μA
I <sub>IH</sub>	Input HIGH Current	V <sub>IN</sub> = V <sub>DD</sub>		—	100	μA
V <sub>OL</sub>	Output LOW Voltage	Standard Drive	I <sub>OL</sub> = 8mA	—	0.4	V
		High Drive	I <sub>OL</sub> = 12mA (-1H)			
V <sub>OH</sub>	Output HIGH Voltage	Standard Drive	I <sub>OH</sub> = -8mA	2.4	—	V
		High Drive	I <sub>OH</sub> = -12mA (-1H)			
I <sub>DD_PD</sub>	Power Down Current	REF = 0MHz		—	25	μA
I <sub>DD</sub>	Supply Current	Unloaded Outputs at 66.66MHz		—	35	mA

**SWITCHING CHARACTERISTICS (2305B-1) - INDUSTRIAL** <sup>(1,2)</sup>

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t <sub>f</sub>	Output Frequency	10pF Load	10	—	133	MHz
		30pF Load	10	—	100	
	Duty Cycle = t <sub>2</sub> ÷ t <sub>1</sub>	Measured at 1.4V, F <sub>OUT</sub> = 66.66MHz	40	50	60	%
t <sub>r</sub>	Rise Time	Measured between 0.8V and 2V	—	—	2.5	ns
t <sub>f</sub>	Fall Time	Measured between 0.8V and 2V	—	—	2.5	ns
t <sub>s</sub>	Output to Output Skew	All outputs equally loaded	—	—	250	ps
t <sub>d</sub>	Delay, REF Rising Edge to CLKOUT Rising Edge	Measured at V <sub>DD</sub> /2	—	0	±350	ps
t <sub>r</sub>	Device-to-Device Skew	Measured at V <sub>DD</sub> /2 on the CLKOUT pins of devices	—	0	700	ps
t <sub>j</sub>	Cycle-to-Cycle Jitter	Measured at 66.66MHz, loaded outputs	—	50	175	ps
t <sub>LOCK</sub>	PLL Lock Time	Stable power supply, valid clock presented on REF pin	—	—	1	ms

## NOTES:

1. REF Input has a threshold voltage of V<sub>DD</sub>/2.
2. All parameters specified with loaded outputs.

**SWITCHING CHARACTERISTICS (2305B-1H) - INDUSTRIAL** <sup>(1,2)</sup>

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
t <sub>f</sub>	Output Frequency	10pF Load	10	—	133	MHz
		30pF Load	10	—	100	
	Duty Cycle = t <sub>2</sub> ÷ t <sub>1</sub>	Measured at 1.4V, F <sub>OUT</sub> = 66.66MHz	40	50	60	%
	Duty Cycle = t <sub>2</sub> ÷ t <sub>1</sub>	Measured at 1.4V, F <sub>OUT</sub> < 50MHz	45	50	55	%
t <sub>r</sub>	Rise Time	Measured between 0.8V and 2V	—	—	1.5	ns
t <sub>f</sub>	Fall Time	Measured between 0.8V and 2V	—	—	1.5	ns
t <sub>s</sub>	Output to Output Skew	All outputs equally loaded	—	—	250	ps
t <sub>d</sub>	Delay, REF Rising Edge to CLKOUT Rising Edge	Measured at V <sub>DD</sub> /2	—	0	±350	ps
t <sub>r</sub>	Device-to-Device Skew	Measured at V <sub>DD</sub> /2 on the CLKOUT pins of devices	—	0	700	ps
t <sub>s</sub>	Output Slew Rate	Measured between 0.8V and 2V using Test Circuit #2	1	—	—	V/ns
t <sub>j</sub>	Cycle-to-Cycle Jitter	Measured at 66.66MHz, loaded outputs	—	—	175	ps
t <sub>LOCK</sub>	PLL Lock Time	Stable power supply, valid clock presented on REF pin	—	—	1	ms

## NOTES:

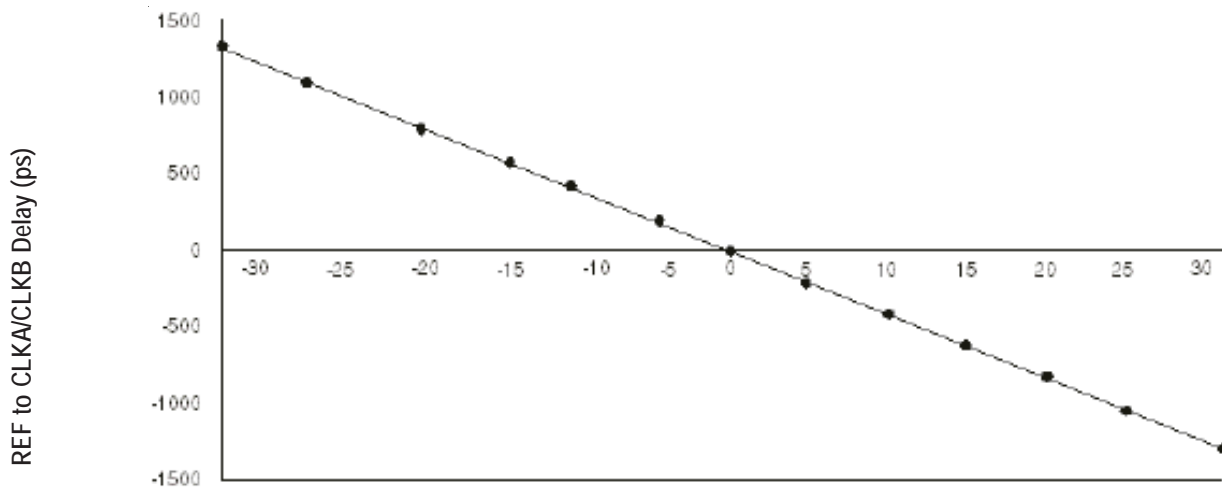
1. REF Input has a threshold voltage of V<sub>DD</sub>/2.
2. All parameters specified with loaded outputs.

## ZERO DELAY AND SKEW CONTROL

All outputs should be uniformly loaded in order to achieve Zero I/O Delay. Since the CLKOUT pin is the internal feedback for the PLL, its relative loading can affect and adjust the input/output delay. The Output Load Difference diagram illustrates the PLL's relative loading with respect to the other outputs that can adjust the Input-Output (I/O) Delay.

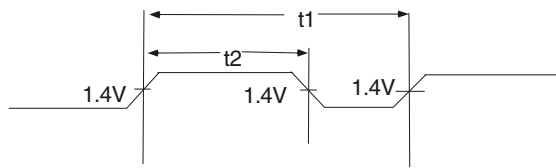
For designs utilizing zero I/O Delay, all outputs including CLKOUT must be equally loaded. Even if the output is not used, it must have a capacitive load equal to that on the other outputs in order to obtain true zero I/O Delay. If I/O Delay adjustments are needed, use the Output Load Difference diagram to calculate loading differences between the CLKOUT pin and other outputs. For zero output-to-output skew, all outputs must be loaded equally.

REF TO CLKA/CLKB RELAY vs. OUTPUT LOAD DIFFERENCE BETWEEN CLKOUT PIN AND CLKA/CLKB PINS

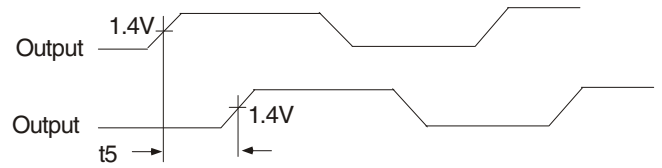


OUTPUT LOAD DIFFERENCE BETWEEN CLKOUT PIN AND CLKA/CLKB PINS (pF)

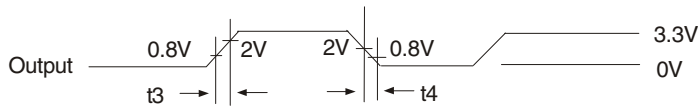
## SWITCHING WAVEFORMS



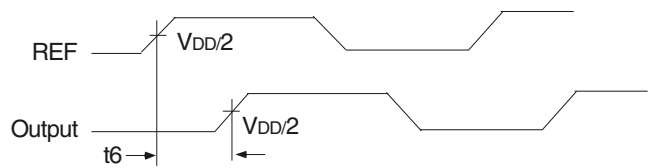
*Duty Cycle Timing*



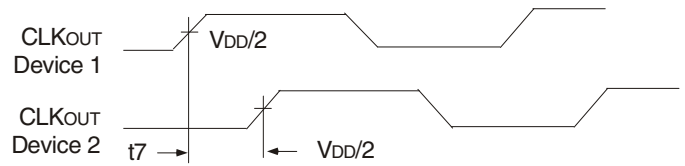
*Output to Output Skew*



*All Outputs Rise/Fall Time*

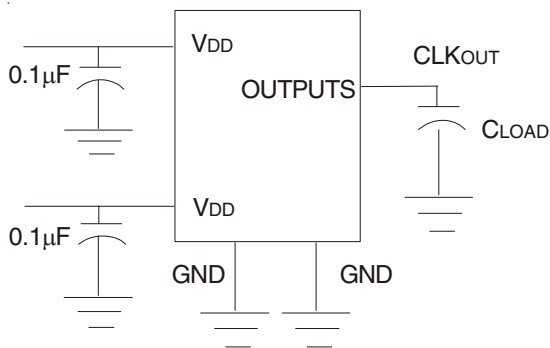


*Input to Output Propagation Delay*

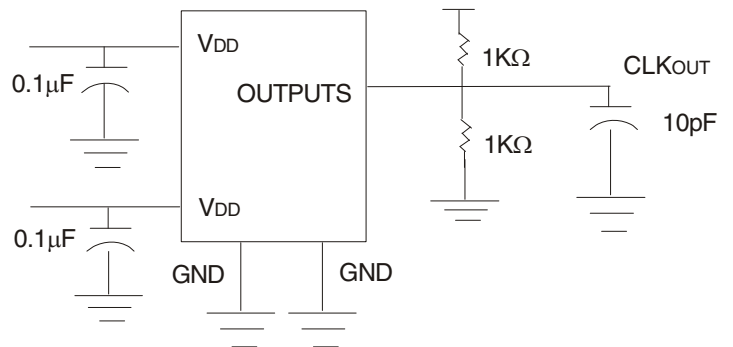


*Device to Device Skew*

## TEST CIRCUITS



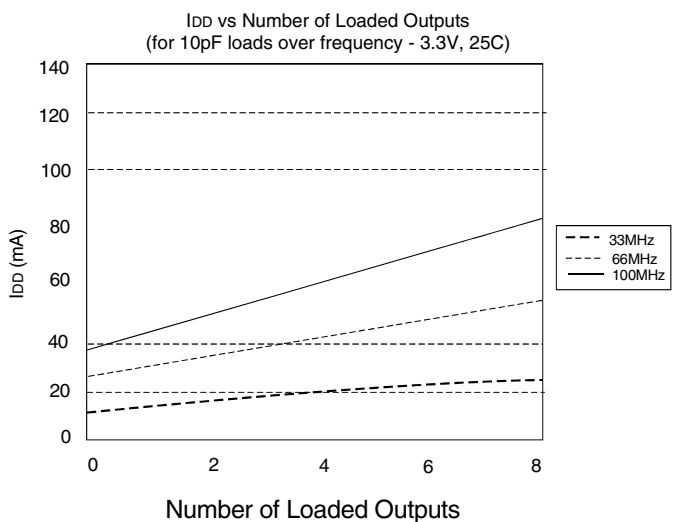
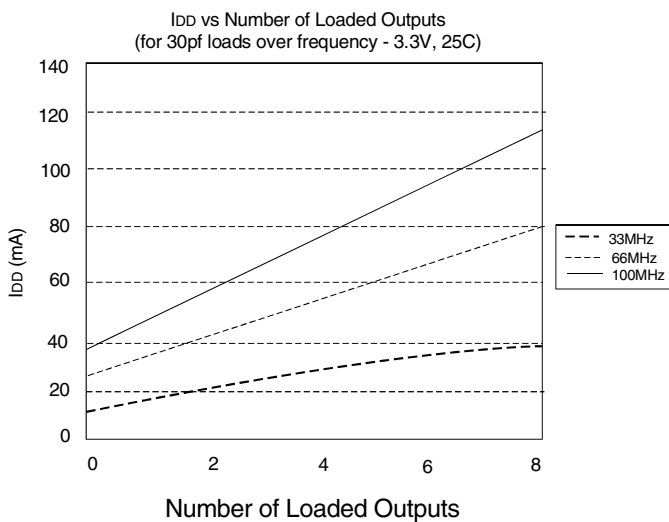
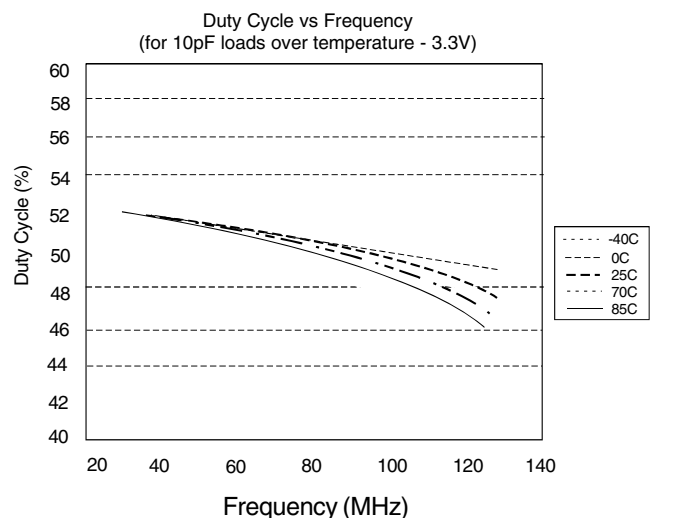
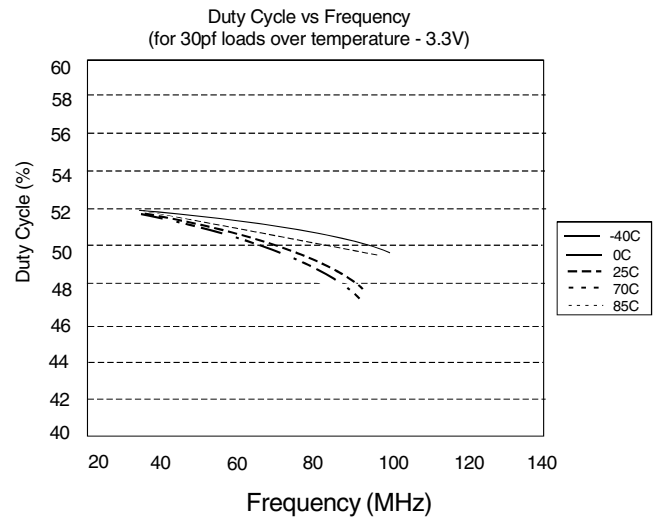
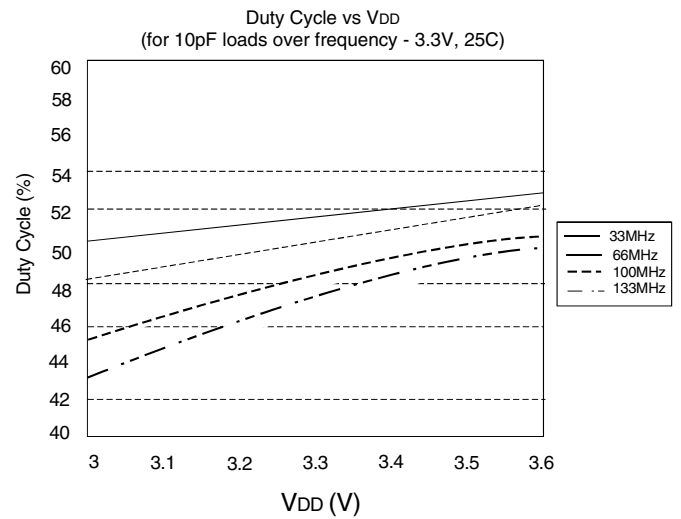
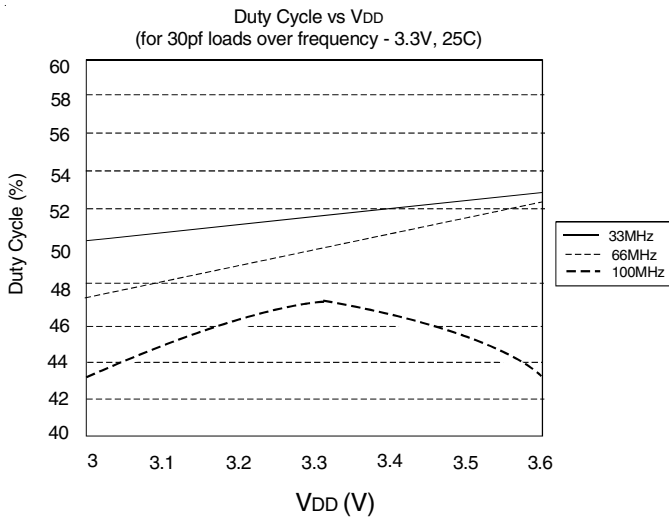
*Test Circuit 1 (all Parameters Except  $t_8$ )*



*Test Circuit 2 ( $t_8$ , Output Slew Rate On -1H Devices)*



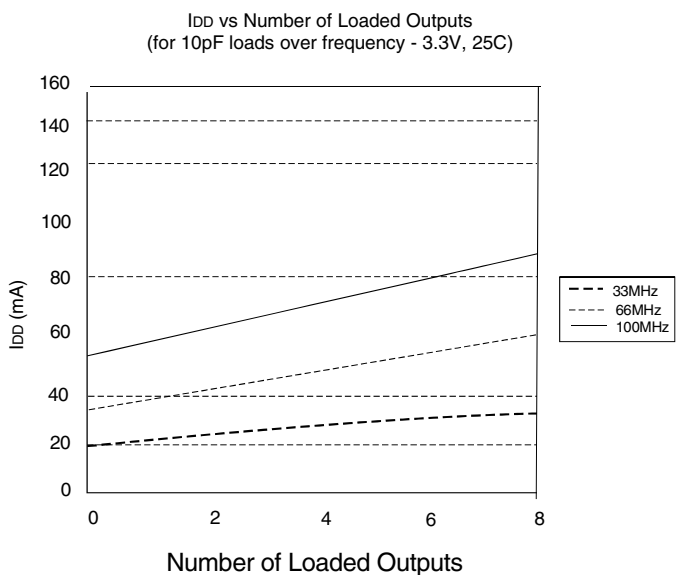
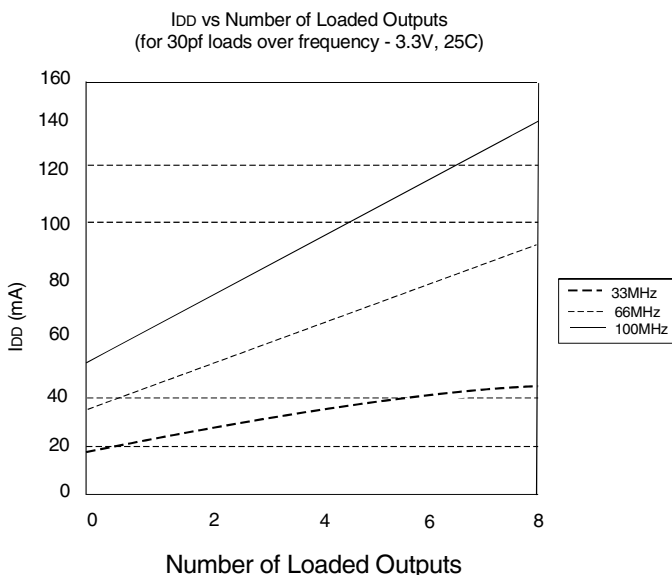
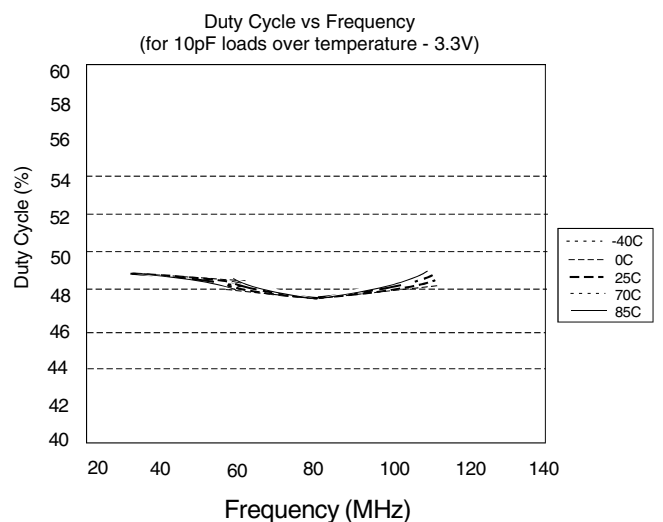
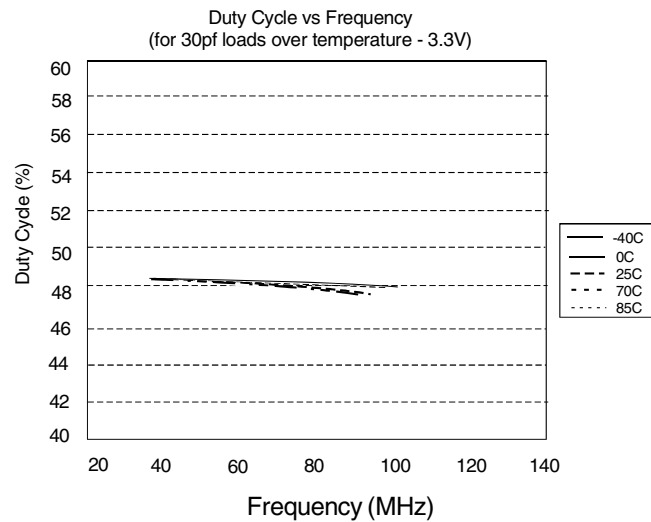
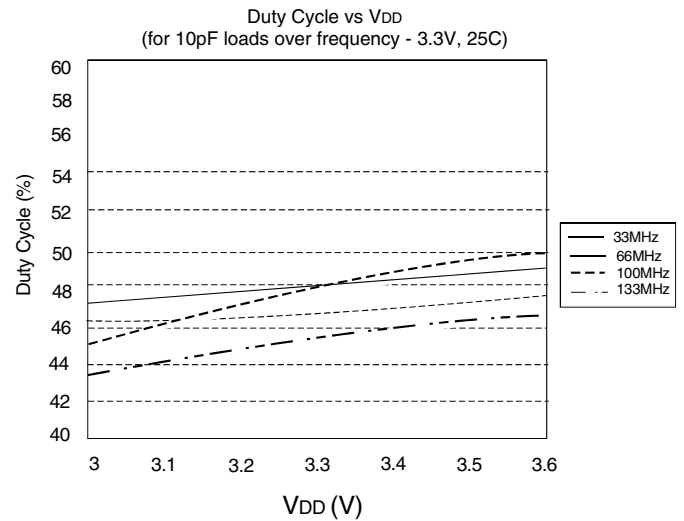
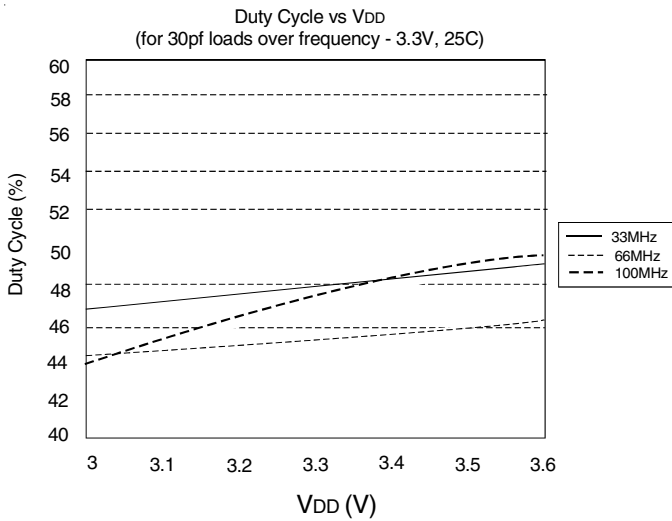
## TYPICAL DUTY CYCLE<sup>(1)</sup> AND I<sub>DD</sub> TRENDS<sup>(2)</sup> FOR IDT2305B-1



NOTES:

- Duty Cycle is taken from typical chip measured at 1.4V.
- I<sub>DD</sub> data is calculated from  $I_{DD} = I_{CORE} + nCVf$ , where  $I_{CORE}$  is the unloaded current. (n = Number of outputs; C = Capacitance load per output (F); V = Supply Voltage (V); f = Frequency (Hz))

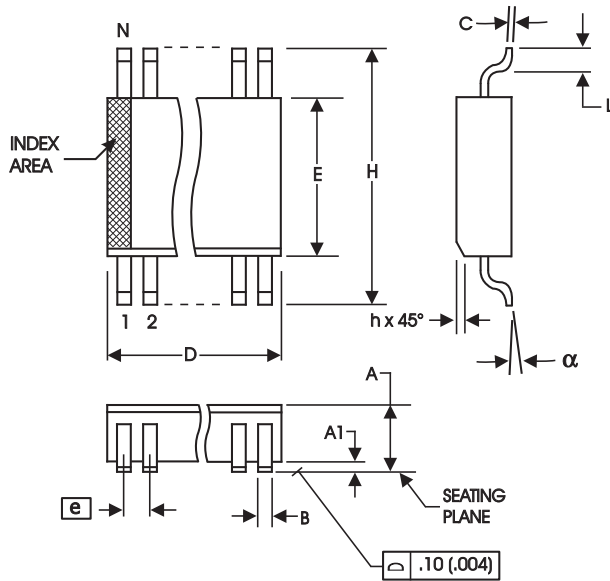
## TYPICAL DUTY CYCLE<sup>(1)</sup> AND I<sub>DD</sub> TRENDS<sup>(2)</sup> FOR IDT2305B-1H



NOTES:

- Duty Cycle is taken from typical chip measured at 1.4V.
- I<sub>DD</sub> data is calculated from  $I_{DD} = I_{CORE} + nCfV$ , where  $I_{CORE}$  is the unloaded current. ( $n$  = Number of outputs;  $C$  = Capacitance load per output (F);  $V$  = Supply Voltage (V);  $f$  = Frequency (Hz))

### 8-Pin SOIC Package Drawing and Dimensions



150 mil (Narrow Body) SOIC

150 mil (Narrow Body) SOIC

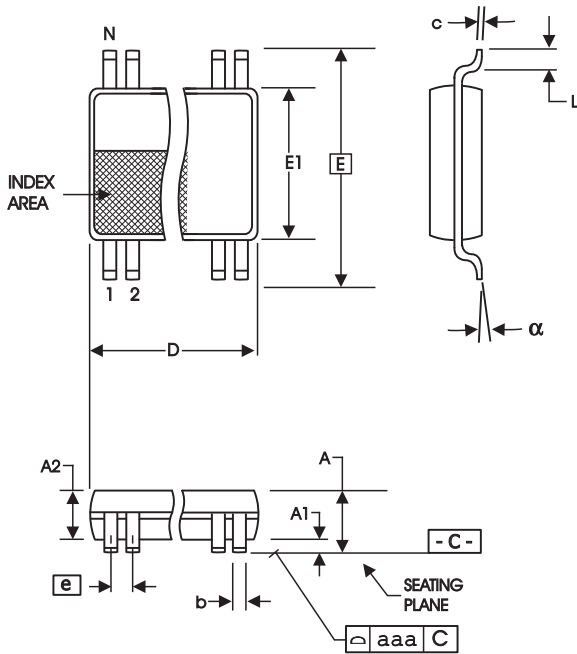
SYMBOL	In Millimeters		In Inches	
	COMMON DIMENSIONS		COMMON DIMENSIONS	
	MIN	MAX	MIN	MAX
A	1.35	1.75	.0532	.0688
A1	0.10	0.25	.0040	.0098
B	0.33	0.51	.013	.020
C	0.19	0.25	.0075	.0098
D	SEE VARIATIONS		SEE VARIATIONS	
E	3.80	4.00	.1497	.1574
e	1.27 BASIC		0.050 BASIC	
H	5.80	6.20	.2284	.2440
h	0.25	0.50	.010	.020
L	0.40	1.27	.016	.050
N	SEE VARIATIONS		SEE VARIATIONS	
alpha	0°	8°	0°	8°

VARIATIONS

N	D mm.		D (inch)	
	MIN	MAX	MIN	MAX
8	4.80	5.00	.1890	.1968

Reference Doc.: JEDEC Publication 95, MS-012  
10-0030

## 8-Pin TSSOP Package Drawing and Dimensions



4.40 mm. Body, 0.65 mm. Pitch TSSOP  
(173 mil) (25.6 mil)

SYMBOL	In Millimeters COMMON DIMENSIONS		In Inches COMMON DIMENSIONS	
	MIN	MAX	MIN	MAX
A	--	1.20	--	.047
A1	0.05	0.15	.002	.006
A2	0.80	1.05	.032	.041
b	0.19	0.30	.007	.012
c	0.09	0.20	.0035	.008
D	SEE VARIATIONS		SEE VARIATIONS	
E	6.40 BASIC		0.252 BASIC	
E1	4.30	4.50	.169	.177
e	0.65 BASIC		0.0256 BASIC	
L	0.45	0.75	.018	.030
N	SEE VARIATIONS		SEE VARIATIONS	
a	0°	8°	0°	8°
aaa	--	0.10	--	.004

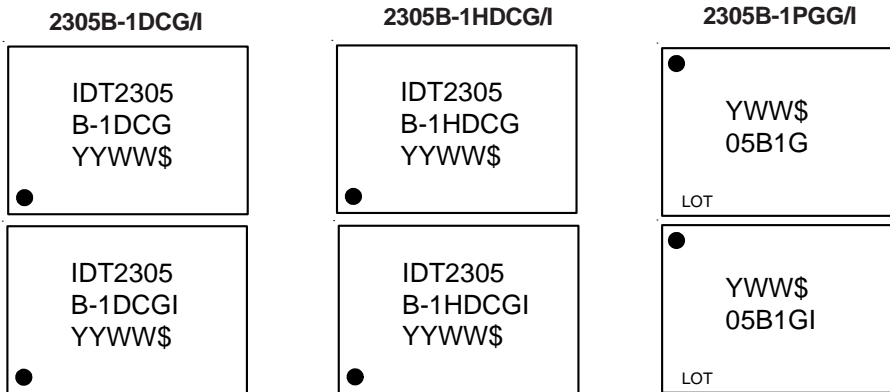
### VARIATIONS

N	D mm.		D (inch)	
	MIN	MAX	MIN	MAX
8	2.90	3.10	.114	.122

Reference Doc.: JEDEC Publication 95, MO-153

10-0035

## MARKING DIAGRAMS

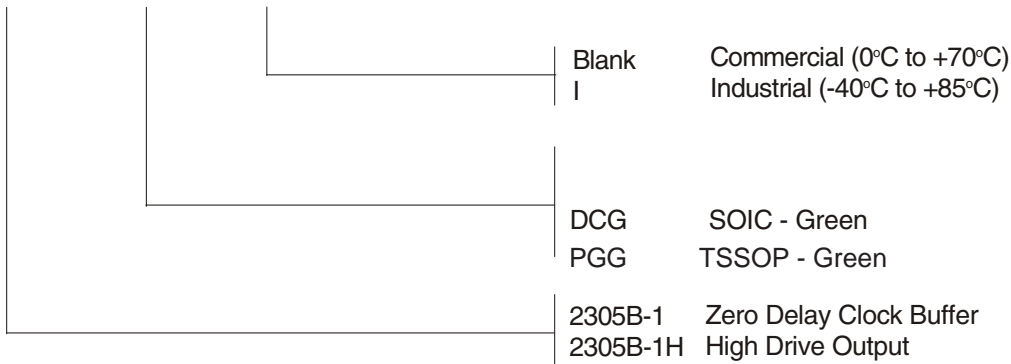


Notes:

1. "G" denotes Pb-free (green)
2. "YYWW" or "YWW" is the last digit(s) of the year and week that the part was assembled.
3. "I" denotes industrial temperature grade.
4. "\$" denotes mark code.
5. "LOT" denotes lot number.

## ORDERING INFORMATION

IDT XXXXX XX X  
Device Type Package Process



Ordering Code	Package Type	Operating Range
2305B-1DCG8 (tape and reel)	8-Pin SOIC	Commercial
2305B-1DCG	8-Pin SOIC	Commercial
2305B-1DCGI8 (tape and reel)	8-Pin SOIC	Industrial
2305B-1DCGI	8-Pin SOIC	Industrial
2305B-1HDCG8 (tape and reel)	8-Pin SOIC	Commercial
2305B-1HDCG	8-Pin SOIC	Commercial
2305B-1HDCGI8 (tape and reel)	8-Pin SOIC	Industrial
2305B-1HDCGI	8-Pin SOIC	Industrial
2305B-1PGG8 (tape and reel)	8-Pin TSSOP	Commercial
2305B-1PGG	8-Pin TSSOP	Commercial
2305B-1PGGI8 (tape and reel)	8-Pin TSSOP	Industrial
2305B-1PGGI	8-Pin TSSOP	Industrial



**CORPORATE HEADQUARTERS**  
6024 Silver Creek Valley Road  
San Jose, CA 95138

for SALES:  
800-345-7015 or 408-284-8200  
fax: 408-284-2775  
www.idt.com

for Tech Support:  
clockhelp@idt.com